

600V N-Channel MOSFET

General Features

- Proprietary New Planar Technology
- > $R_{DS(ON),typ}=0.41 \ \Omega @V_{GS}=10V$
- Low Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode

Applications

- Adaptor Charger
- SMPS Power Supply
- LCD Panel Power

Ordering Information

Part Number	Package	Brand
PTP16N60	TO-220	ľ
PTA16N60	TO-220F	ľ

Absolute Maximum Ratings

Symbol	Parameter	PTP16N60	PTA16N60	Unit
V _{DSS}	Drain-to-Source Voltage ^[1]	600		V
V _{GSS}	Gate-to-Source Voltage	±3	30	v
I _D	Continuous Drain Current	1	6	
I _{D @ Tc =100} ℃	Continuous Drain Current @ Tc=100°C	11	.5	А
I _{DM}	Pulsed Drain Current at V _{GS} =10V ^[2]	6		
E _{AS}	Single Pulse Avalanche Energy	1000		mJ
dv/dt	Peak Diode Recovery dv/dt ^[3]	5.0		V/ns
Р	Power Dissipation	180	60	W
P _D	Derating Factor above 25°C	1.11	0.48	W/℃
T _L T _{PAK}	Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10 seconds, Package Body for 10 seconds	300 260		°C
T _J & T _{STG}	Operating and Storage Temperature Range	-55 to		

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

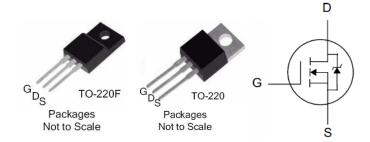
Thermal Characteristics

Symbol	Parameter	PTP16N60	PTA16N60	Unit
R _{θJC}	Thermal Resistance, Junction-to-Case	0.69	2.08	°C AA/
R _{θJA}	Thermal Resistance, Junction-to-Ambient	62	100	°C/W

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Lead Free Package and Finish

BV _{DSS}	R _{DS(ON),typ.}	I _D
600V	0.41Ω	16A



 $T_C \text{=} 25^\circ\!\mathrm{C}$ unless otherwise specified



Electrical Characteristics

OFF Characteristics $T_J = 25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	600			V	V_{GS} =0V, I _D =250uA
				10	uA -	V _{DS} =600V, V _{GS} =0V
I _{DSS}	Drain-to-Source Leakage Current	-		100		V _{DS} =480V, V _{GS} =0V, T _J =125℃
	Cate to Source Lookage Current			+100	n (V_{GS} =+30V, V_{DS} =0V
I _{GSS} (Gate-to-Source Leakage Current			-100	nA	V _{GS} =-30V, V _{DS} =0V

ON	Chara	cteristics

TJ = 25 °C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
R _{DS(ON)}	Static Drain-to-Source On-Resistance ^[4]		0.41	0.50	Ω	V_{GS} =10V, I _D =8A
V _{GS(TH)}	Gate Threshold Voltage	2.0		4.0	V	$V_{DS}=V_{GS}$, $I_D=250$ uA
gfs	Forward Transconductance ^[4]		15		S	VDS=15V,ID=8A

Dynamic Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
C _{iss}	Input Capacitance		2442)/ - 0)/
C _{rss}	Reverse Transfer Capacitance		18.5		pF	V _{GS} =0V, V _{DS} =25V,
C _{oss}	Output Capacitance		218			f=1.0MH _z
Qg	Total Gate Charge		54			
Q _{gs}	Gate-to-Source Charge		12		nC	V_{DD} =300V, I _D =16A, V_{GS} =0 to 10V
Q _{gd}	Gate-to-Drain (Miller) Charge		21			

Resistive Switching Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
td(ON)	Turn-on Delay Time		15			
trise	Rise Time		52		- nS	V _{DD} =300V, I _D =16A, V _{GS} = 10V Rg=6.1 Ω
td(OFF)	Turn-Off Delay Time		59			
tfall	Fall Time		72			



Source-Drain Body Diode Characteristics

 $T_J=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min	Тур.	Max.	Unit	Test Conditions
I _{SD}	Continuous Source Current ^[4]			16	А	Integral PN-diode in
I _{SM}	Pulsed Source Current ^[4]			64		MOSFET
V _{SD}	Diode Forward Voltage			1.5	V	I _S =16A, V _{GS} =0V
trr	Reverse recovery time		380		ns	V _{GS} =0V ,I _F =16A,
Qrr	Reverse recovery charge		2.6		uC	di⊧/dt=100A/µs

Note:

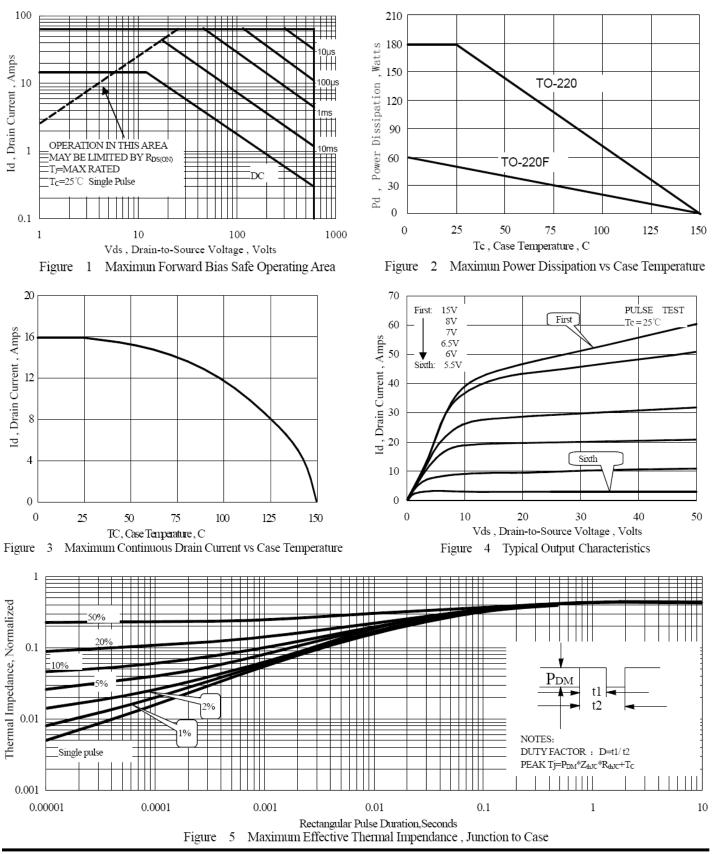
[1] T_J=+25℃ to +150℃

[2] Repetitive rating; pulse width limited by maximum junction temperature. [3] ISD= 16A di/dt < 100 A/ μ s, VDD < BVDss, TJ=+150 °C.

^[4] Pulse width≤380µs; duty cycle≤2%.

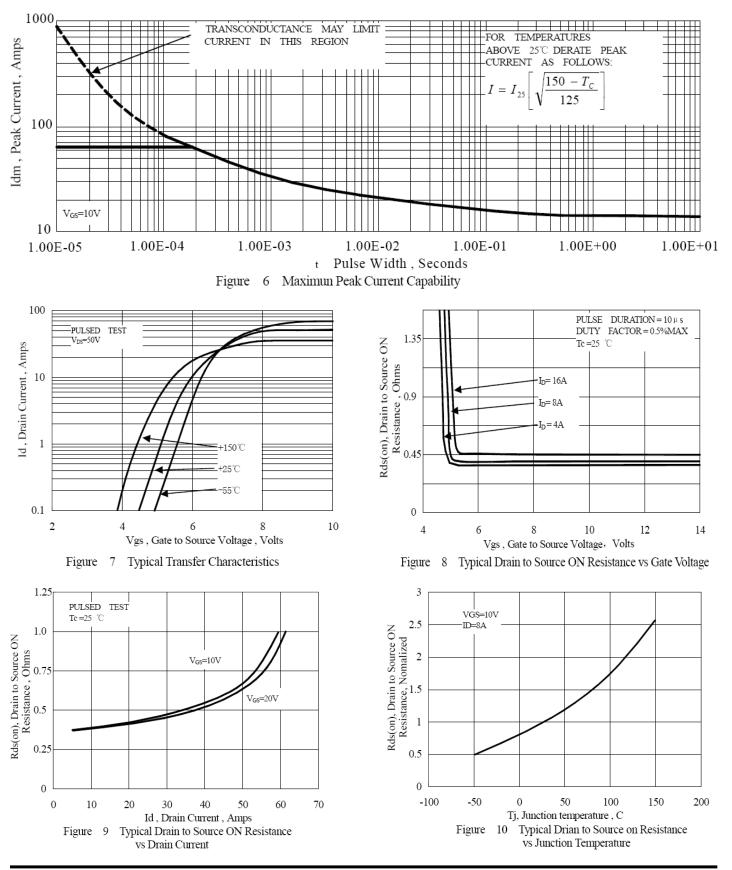


Typical Characteristics



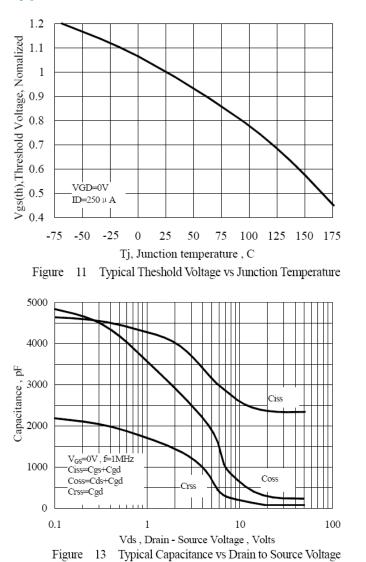


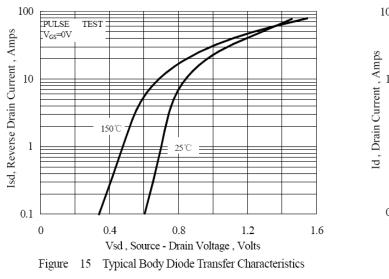
Typical Characteristics(Cont.)

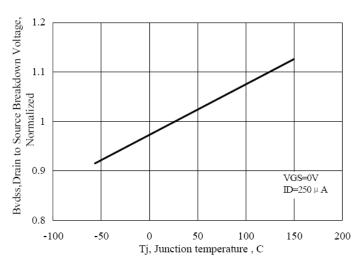


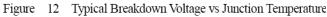


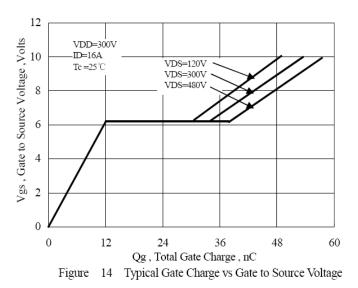
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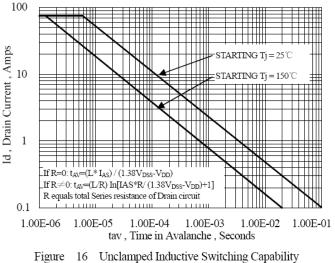






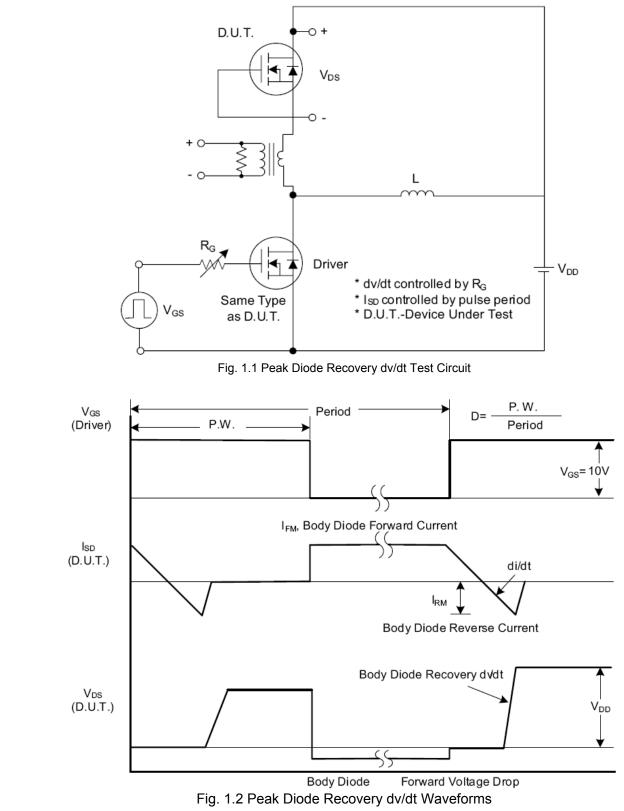








Test Circuits and Waveforms





Test Circuits and Waveforms (Cont.)

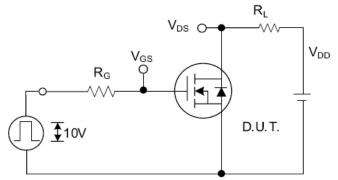


Fig. 2.1 Switching Test Circuit

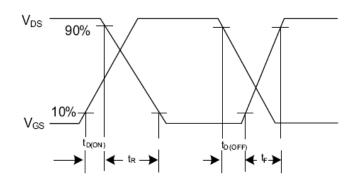


Fig. 2.2 Switching Waveforms

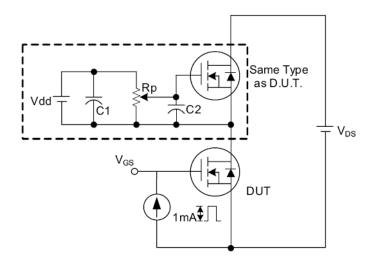


Fig. 3 . 1 Gate Charge Test Circuit

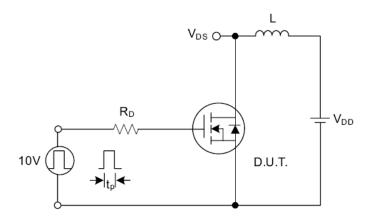


Fig. 4.1 Unclamped Inductive Switching Test Circuit

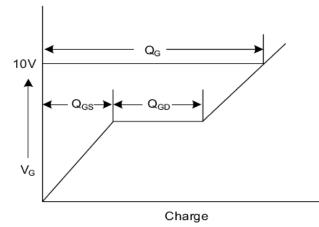
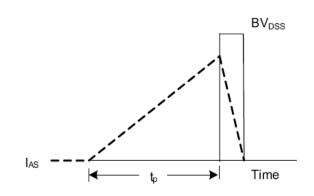
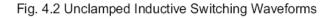


Fig. 3.2 Gate Charge Waveform





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